

Notice of References Cited	Application/Control No. 10/716,307	Applicant(s)/Patent Under Reexamination YERIAN ET AL.	
	Examiner Maria Veronica D. Ewald	Art Unit 1722	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-3,741,699	06-1973	Arpajian et al.	425/145
*	C	US-6,380,517	04-2002	Morgan, Allan C.	219/389
*	D	US-3,645,505	02-1972	McLeod et al.	366/160.3
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	K	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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